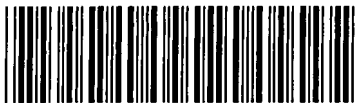


**Search Notes**

Application/Control No.

10/624,524

Examiner

Nhan T. Tran

Applicant(s)/Patent under  
Reexamination

LEE ET AL.

Art Unit

2622

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
PGPUB interference text search - see search history printout		10/10/2007	NT

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated EAST search (USPAT, PGPUB, JPO, EPO, DERWENT, IBM_TDB)	10/10/2007	NT
Text search all classes 348, 455 and 379	10/10/2007	NT
Text search all classes in databases listed above	10/10/2007	NT
Updated inventorship search - see search history printout	10/10/2007	NT